

Claims:

- 1 1. An integrated circuit comprising: a gate array architecture;
2 said gate array architecture including a semiconductor substrate having a plurality of N-type
3 diffusion regions and P-type diffusion regions; said diffusion regions having partially overlying
4 polysilicon landing sites to form N-type and P-type transistors;
5 wherein the regions are relatively-sized to form two distinct transistor sizes, smaller N- and
6 P-type transistors and larger N- and P-type transistors.
- 1 2. The integrated circuit of claim 1, wherein the ratio between the two distinct transistor sizes
2 is on the order of one-third.
- 1 3. The integrated circuit of claim 2, wherein the ratio between the capacitance of the larger
2 and smaller relatively sized transistors is on the order of one-third.
- 1 4. The integrated circuit of claim 1, wherein said partially overlying polysilicon landings for the
2 smaller and larger transistors are not connected.
- 1 5. The integrated circuit of claim 4, and further comprising an interconnect overlying said gate
2 array architecture;
3 the interconnect being adapted to connect the transistors of the gate array architecture to
4 form a flip-flop.
- 1 6. The integrated circuit of claim 5, wherein the interconnect is further adapted to connect
2 the transistors of the gate array architecture so that the internal clock buffers of the flip-flop are
3 formed from the smaller transistors.
- 1 7. The integrated circuit of claim 6, wherein said gate array architecture is repeated in said
2 integrated circuit.
- 1 8. The integrated circuit of claim 6, wherein said integrated circuit is incorporated in a
2 communications device.
- 1 9. The integrated circuit of claim 6, wherein said integrated circuit is attached to a
2 motherboard.
- 1 10. The integrated circuit of claim 9, wherein said integrated circuit is incorporated in a
2 personal computer.
- 1 11. The integrated circuit of claim 10, wherein said personal computer comprises one of a
2 laptop and a desktop computer.
- 1 12. The integrated circuit of claim 1, wherein successive rows of small diffusion regions are
2 followed by successive rows of regular-sized diffusion regions;
3 wherein immediately successive rows within similarly-sized diffusion regions have opposite
4 polarity.

- 1 13. A method of fabricating an integrated circuit chip comprising:
2 processing a semiconductor substrate to form a gate array architecture of transistors in the
3 substrate, the gate array architecture comprising a plurality of N-type diffusion regions and P-type
4 diffusion regions; said diffusion regions having partially overlying polysilicon landing sites to form
5 N-type and P-type transistors;
6 wherein the regions are relatively-sized to form two distinct transistor sizes, smaller N- and
7 P-type transistors and larger N- and P-type transistors.
- 1 14. The method of claim 13, wherein said semiconductor substrate comprises a silicon
2 substrate.
- 1 15. The method of claim 14, wherein processing said silicon substrate to form a gate array
2 architecture comprises:
3 forming said partially overlying polysilicon landings so that said landings for the smaller and
4 larger transistors are not connected.
- 1 16. The method of claim 15, wherein the ratio between the two distinct transistor sizes is on
2 the order of one-third.
- 1 17. The method of claim 16, wherein the ratio between the capacitance of the larger and
2 smaller relatively sized transistors is on the order of one-third.
- 1 18. The method of claim 15, and further comprising:
2 forming a metallization interconnect overlying said gate array architecture.
- 1 19. The method of claim 18, wherein forming a metallization interconnect comprises forming a
2 metallization interconnect that connects the transistors of the gate array architecture to form a
3 flip-flop.
- 1 20. The method of claim 19, wherein forming a metallization interconnect comprises forming
2 an interconnect that connects the transistors of the gate array architecture so that the internal
3 clock buffers of the flip-flop are formed from the smaller transistors.
- 1 21. An article comprising: a storage medium, said storage medium having instructions stored
2 thereon, said instructions, when executed, resulting in the capability to design the layout of an
3 integrated circuit chip for fabrication, the integrated circuit chip including a gate array architecture,
4 the gate array architecture comprising a plurality of N-type diffusion regions and P-type diffusion
5 regions; said diffusion regions having partially overlying polysilicon landing sites to form N-type
6 and P-type transistors;
7 wherein the regions are relatively-sized to form two distinct transistor sizes, smaller N- and
8 P-type transistors and larger N- and P-type transistors.

1 22. The article of claim 21, wherein said instructions, when executed, result in the capability to
2 design the layout of the gate array architecture, wherein the ratio between the two distinct
3 transistor sizes is on the order of one-third.

1 23. The article of claim 22, wherein said instructions, when executed, result in the capability to
2 design the layout of the gate array architecture, wherein said partially overlying polysilicon
3 landings for the smaller and larger transistors are not connected.

1 24. The article of claim 23, wherein said instructions, when executed, result in the capability to
2 design the layout of a metallization interconnect overlying said gate array architecture.

1 25. The article of claim 24, wherein said instructions, when executed, result in the capability to
2 design the layout of a metallization interconnect overlying said gate array architecture, wherein
3 said metallization interconnect couples the transistors of the gate array architecture to form a flip-
4 flop.

1 26. The article of claim 25, wherein said instructions, when executed, result in the capability to
2 design the layout of a metallization interconnect overlying said gate array architecture that
3 connects the transistors of the gate array architecture so that the internal clock buffers of the flip-
4 flop are formed from the smaller transistors.